
**Dielektrične in uporovne lastnosti trdnih izolacijskih materialov - 2-1. del:
Relativna permitivnost in faktor dielektričnih izgub - Tehnične frekvence (0,1 Hz -
10 MHz) - Metode AC**

Dielectric and resistive properties of solid insulating materials - Part 2-1: Relative permittivity and dissipation factor - Technical frequencies (0,1 Hz - 10 MHz) - AC Methods

Dielektrične in uporovne lastnosti trdnih izolacijskih materialov - 2-1. del: Relativna permitivnost in faktor izgube - Tehnične frekvence (0,1 Hz – 10 MHz), metode AC (IEC 62631-2-1:2018)

Propriétés diélectriques et résistives des matériaux isolants solides - Partie 2-1: Permittivité relative et facteur de dissipation - Fréquences techniques (0,1 Hz à 10 MHz) - Méthodes en courant alternatif

Ta slovenski standard je istoveten z: prEN IEC 62631-2-1:2026

ICS:

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29.035.01	Izolacijski materiali na splošno	Insulating materials in general

oSIST prEN IEC 62631-2-1:2026**en**

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112/721/CDV

COMMITTEE DRAFT FOR VOTE (CDV)

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IEC TC 112 : EVALUATION AND QUALIFICATION OF ELECTRICAL INSULATING MATERIALS AND SYSTEMS

SECRETARIAT:

Germany

SECRETARY:

Mr Bernd Komanschek

OF INTEREST TO THE FOLLOWING COMMITTEES:

TC 10, TC 15

HORIZONTAL FUNCTION(S):

ASPECTS CONCERNED:

Electricity transmission and distribution

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TITLE:

Dielectric and resistive properties of solid insulating materials – Part 2-1: Relative permittivity and dissipation factor – Technical Frequencies (0,1 Hz - 10 MHz) – AC Methods

PROPOSED STABILITY DATE: 2031

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

**Dielectric and resistive properties of solid insulating materials –
Part 2-1: Relative permittivity and dissipation factor –
Technical Frequencies (0,1 Hz - 10 MHz) – AC Methods**

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International Standard IEC 62631-2-1 has been prepared by IEC technical committee 112: Evaluation and qualification of electrical insulating materials and systems.

This second edition cancels and replaces the first edition published in 2017. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- Removal of liquid electrode
- Editorial updates

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The text of this standard is based on the following documents:

Draft	Report on voting

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62631 series, published under the general title *Dielectric and resistive properties of solid insulating materials*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

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